

---

# EE566 Solid State Devices

Spring 2005

Dept of Electrical Engineering

University of Notre Dame

Instructor: Debdeep Jena ([djena@nd.edu](mailto:djena@nd.edu), x8835)

---

## Assignment 5

Posted: 02/21/2005

Due: 02/28/2005

### Reading

Chapter 5 of Muller/Kamins/Chan (**MKC**).

### Problem 1<sup>1</sup> (Currents in long-base p-n junction - practice)

Problem 5.11, **MKC**.

### Problem 2 (Long and Short base p-n junction currents)

We will henceforth call the heavily doped side of an asymmetrical p-n junction as the *EMITTER*, and the lightly doped side the *BASE*, to prepare for the jargon used in bipolar transistors. Consider an ideal  $n^+p$  junction made of GaAs ( $N_D=2 \cdot 10^{17}/\text{cm}^3$ ,  $N_A=10^{15}/\text{cm}^3$ ) at 300K. Assume that the minority carrier lifetime of electrons in the p-side and holes in the n-side is  $\tau_n=\tau_p=0.2\mu\text{s}$ . Look up data sheets for anything else you might need.

- Calculate the saturation current density  $J_0$  for the diode (current density is  $J=J_0[\exp(V/V_{th})-1]$ ).
- Sketch* the minority and majority carrier profiles outside the depletion region at zero bias, and at a forward bias of  $V=0.5\text{Volt}$ . Label length scales (diffusion lengths, etc).
- Calculate and *sketch* the electron and hole current components (both diffusion and recombination) outside the depletion region as a function of distance at this forward bias. Which carriers (minority or majority) dominate the current flow on each side of the junction?
- Redo parts a) to c) for a *short-base* diode, with the *total* base width (thickness of the p-side)  $W_B=2\mu\text{m}$ . Verify that  $W_B \ll L_n$ , where  $L_n$  is the minority carrier diffusion length in the base. Make reasonable approximations (linearize slow exponentials, etc) to simplify the problem.
- Finally, what we are waiting for – when is the current larger – for long base or short base? Can you explain intuitively why this must be so?

### Problem 3 (Generation-recombination currents)

Problem 5.10, **MKC**.

### Problem 4 (Heterojunction currents)

Instead of a homojunction diode, let us see what happens if a heterojunction is used as the emitter. The doping density in a GaAs based heterostructure p-n junction is  $N_D=10^{17}/\text{cm}^3$  and  $N_A=10^{16}/\text{cm}^3$ . Design the emitter-base junction by introducing  $\text{Al}_x\text{Ga}_{1-x}\text{As}$  in the emitter layer, such that the total current in the diode improves by a factor of  $\eta=100$  than the normal GaAs p-n junction. Work out the following -

- Solve the zero-bias p-n junction problem and determine the depletion thicknesses on both sides.
- Design your emitter layer such that there are no spikes that impede the current flow. Make generous use of 1D Poisson.
- Explain why the depletion-edge in the emitter should encompass the whole change in the bandgap,  $\Delta E_G$ .
- What are the advantages of the heterojunction over the homojunction? What are the disadvantages?

---

<sup>1</sup> Remember to use proper units and label every figure/plot. Use natural scales such as nm for length, KV/cm for electric fields, and eV for energies. Turn in your answers worked out neatly. Please attach this question sheet to your solution when you turn it in.